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IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re application of: Kossuth et al.

Group Art Unit: 2856

Serial No.: 09/939,139

Examiner: David Rogers

Filed: 08/24/2001

For: HIGH THROUGHPUT FABRIC HANDLE SCREENING

Attorney Docket No.: 1012-109

Commissioner of Patents  
Washington, D.C. 20231

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**RESPONSE AND AMENDMENT**

In response to the Office Action mailed November 6, 2002, please amend the above-identified application as follows and consider the following remarks.

**CLEAN VERSION OF AMENDMENTS**

In the Specification:

On Page 8, line 18, please replace "allows" with -- allow - such that the clean version of the paragraph reads:

Fig. 3A shows a cross-sectional view of one preferred sample holder 102 which is comprised of a first plate 402 having a plurality of through-holes 406 and a second plate 404 having a plurality of openings 407 wherein the through-holes 406 and the openings 407 are aligned with each other forming tunnels 410 within the sample holder 102. Since the array 230 are protruded through the openings 407, their size and shape can affect the fabric handle measurements and are taken into consideration in measuring the fabric handle of the array 230. For instance, each of the openings 407 preferably is large enough for the array sample 230 to collapse upon itself, while still maintaining a portion of itself in physical contact with the walls of the opening 407 during the protrusions. Referring to Fig. 3A, one preferred

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contd